MRF176GU
MRF176GV

The RF MOSFET Line
200/150W, 500MHz, 50V

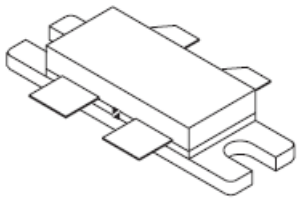
M/A-COM Products
Released - Rev. 07.07

Designed for broadband commercial and military applications using push pull circuits at frequencies to 500 MHz. The high power, high gain and broadband performance of these devices makes possible solid state transmitters for FM broadcast or TV channel frequency bands.

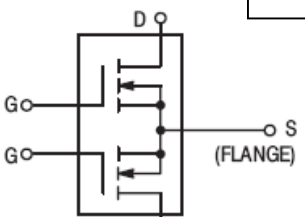
N–Channel enhancement mode

- Electrical performance
  - MRF176GU @ 50 V, 400 MHz (“U” Suffix)
    - Output power — 150 W
    - Power gain — 14 dB typ.
    - Efficiency — 50% typ.
  - MRF176GV @ 50 V, 225 MHz (“V” Suffix)
    - Output power — 200 W
    - Power gain — 17 dB typ.
    - Efficiency — 55% typ.
- 100% ruggedness tested at rated output power
- Low thermal resistance
- Low C_{rss} — 7.0 pF Typ @ V_{DS} = 50 V

Product Image



CASE 375–04, STYLE 2



MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Drain–Source Voltage	V_{DSS}	125	Vdc
Gate–Source Voltage	V_{GS}	±40	Vdc
Drain Current — Continuous	I_D	16	Adc
Total Device Dissipation @ T_C = 25°C Derate above 25°C	P_D	400 2.27	Watts W/°C
Storage Temperature Range	T_{stg}	–65 to +150	°C
Operating Junction Temperature	T_J	200	°C

THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
Thermal Resistance, Junction to Case	$R_{\theta JC}$	0.44	°C/W

Handling and Packaging — MOS devices are susceptible to damage from electrostatic charge. Reasonable precautions in handling and packaging MOS devices should be observed.

ELECTRICAL CHARACTERISTICS (T_C = 25°C unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
OFF CHARACTERISTICS (1)					
Drain–Source Breakdown Voltage (V_{GS} = 0, I_D = 100 mA)	$V_{(BR)DSS}$	125	—	—	Vdc
Zero Gate Voltage Drain Current (V_{DS} = 50 V, V_{GS} = 0)	I_{DSS}	—	—	2.5	mAdc
Gate–Body Leakage Current (V_{GS} = 20 V, V_{DS} = 0)	I_{GSS}	—	—	1.0	µAdc

NOTE:
1. Each side of device measured separately.

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ELECTRICAL CHARACTERISTICS — continued (T_C = 25°C unless otherwise noted)

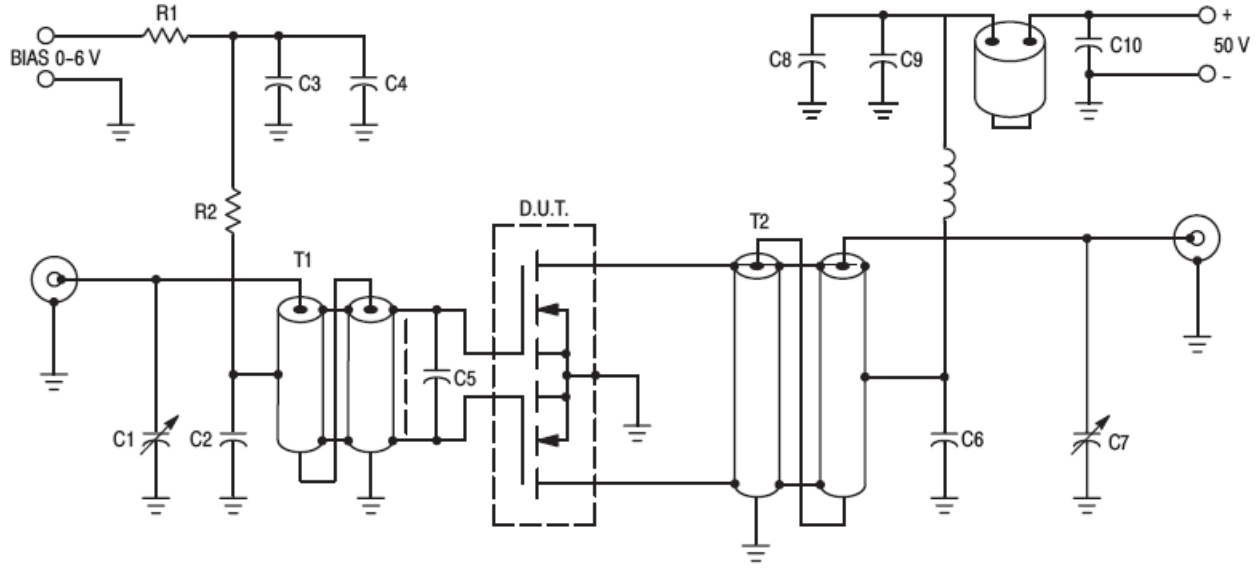
Characteristic	Symbol	Min	Typ	Max	Unit
ON CHARACTERISTICS (1)					
Gate Threshold Voltage (V_{DS} = 10 V, I_D = 100 mA)	$V_{GS(th)}$	1.0	3.0	6.0	Vdc
Drain–Source On–Voltage (V_{GS} = 10 V, I_D = 5.0 A)	$V_{DS(on)}$	1.0	3.0	5.0	Vdc
Forward Transconductance (V_{DS} = 10 V, I_D = 2.5 A)	g_{fs}	2.0	3.0	—	mhos
DYNAMIC CHARACTERISTICS (1)					
Input Capacitance (V_{DS} = 50 V, V_{GS} = 0, f = 1.0 MHz)	C_{iss}	—	180	—	pF
Output Capacitance (V_{DS} = 50 V, V_{GS} = 0, f = 1.0 MHz)	C_{oss}	—	100	—	pF
Reverse Transfer Capacitance (V_{DS} = 50 V, V_{GS} = 0, f = 1.0 MHz)	C_{rss}	—	6.0	—	pF
FUNCTIONAL CHARACTERISTICS — MRF176GV (2) (Figure 1)					
Common Source Power Gain (V_{DD} = 50 Vdc, P_{out} = 200 W, f = 225 MHz, I_{DQ} = 2.0 x 100 mA)	G_{ps}	15	17	—	dB
Drain Efficiency (V_{DD} = 50 Vdc, P_{out} = 200 W, f = 225 MHz, I_{DQ} = 2.0 x 100 mA)	η	50	55	—	%
Electrical Ruggedness (V_{DD} = 50 Vdc, P_{out} = 200 W, f = 225 MHz, I_{DQ} = 2.0 x 100 mA, VSWR 10:1 at all Phase Angles)	ψ	No Degradation in Output Power			

NOTES:
1. Each side of device measured separately.
2. Measured in push–pull configuration.

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C1 — Arco 404, 8.0–60 pF
C2, C3, C6, C8 — 1000 pF Chip
C4, C9 — 0.1 µF Chip
C5 — 180 pF Chip
C7 — Arco 403, 3.0–35 pF
C10 — 0.47 µF Chip, Kemet 1215 or Equivalent
L1 — 10 Turns AWG #16 Enameled Wire,
Close Wound, 1/4″ I.D.

Board material — .062″ fiberglass (G10),
Two sided, 1 oz. copper, $\varepsilon_r \cong 5$

Unless otherwise noted, all chip capacitors
are ATC Type 100 or Equivalent

L2 — Ferrite Beads of Suitable Material
for 1.5–2.0 µH, Total Inductance
R1 — 100 Ohms, 1/2 W
R2 — 1.0 kOhms, 1/2 W
T1 — 4:1 Impedance Ratio RF Transformer.
Can Be Made of 25 Ohm Semirigid
Co–Ax, 47–62 Mils O.D.
T2 — 1:4 Impedance Ratio RF Transformer.
Can Be Made of 25 Ohm Semirigid
Co–Ax, 62–90 Mils O.D.

NOTE: For stability, the input transformer T1 should be loaded with ferrite toroids or beads to increase the common mode inductance. For operation below 100 MHz. The same is required for the output transformer.

Figure 1. 225 MHz Test Circuit

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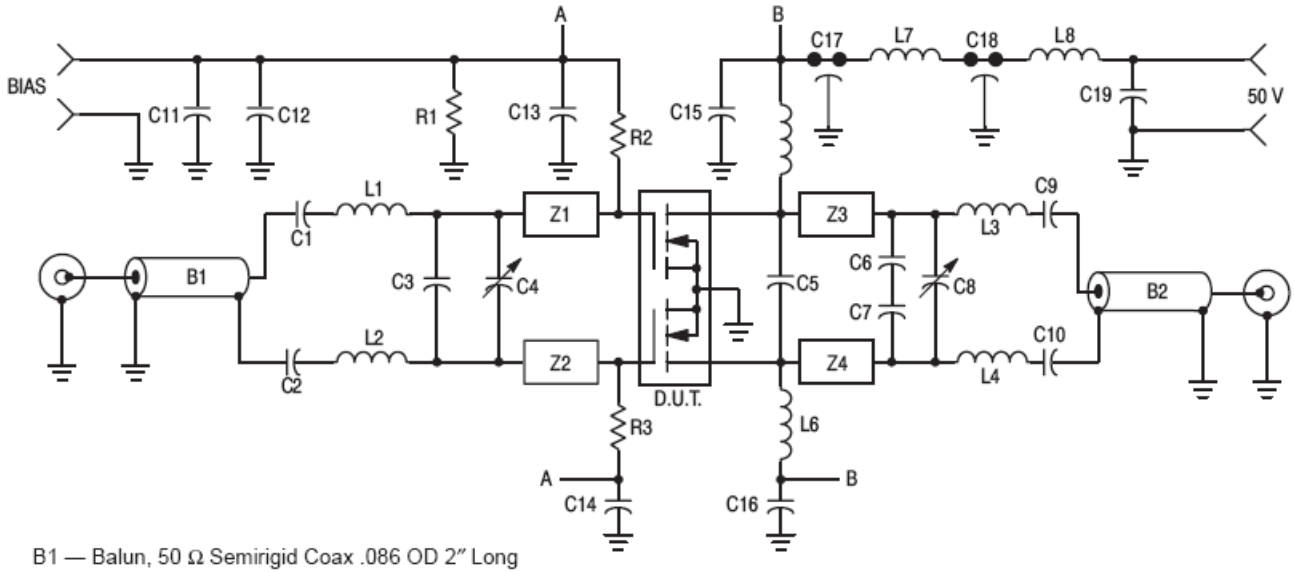
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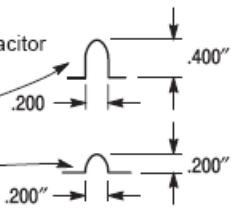
ELECTRICAL CHARACTERISTICS (T_C = 25°C unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
FUNCTIONAL CHARACTERISTICS — MRF176GU (1) (Figure 2)					
Common Source Power Gain (V_{DD} = 50 Vdc, P_{out} = 150 W, f = 400 MHz, I_{DQ} = 2.0 x 100 mA)	G_{ps}	12	14	—	dB
Drain Efficiency (V_{DD} = 50 Vdc, P_{out} = 150 W, f = 400 MHz, I_{DQ} = 2.0 x 100 mA)	η	45	50	—	%
Electrical Ruggedness (V_{DD} = 50 Vdc, P_{out} = 150 W, f = 400 MHz, I_{DQ} = 2.0 x 100 mA, VSWR 10:1 at all Phase Angles)	Ψ	No Degradation in Output Power			

NOTE:
1. Measured in push–pull configuration.



B1 — Balun, 50 Ω Semirigid Coax .086 OD 2″ Long
B2 — Balun, 50 Ω Semirigid Coax .141 OD 2″ Long
C1, C2, C9, C10 — 270 pF ATC Chip Capacitor
C3 — 15 pF ATC Chip Cap
C4, C8 — 1.0–20 pF Piston Trimmer Cap
C5 — 27 pF ATC Chip Cap
C6, C7 — 22 pF Mini Unelco Capacitor
C11, C13, C14, C15, C16 — 0.01 µF Ceramic Capacitor
C12 — 1.0 µF 50 V Tantalum Cap
C17, C18 — 680 pF Feedthru Capacitor
C19 — 10 µF 100 V Tantalum Cap
L1, L2 — Hairpin Inductor #18 W
L3, L4 — Hairpin Inductor #18 W



L5, L6 — 13T #18 W .250 ID
L7 — Ferroxcube VK–200 20/4B
L8 — 3T #18 W .340 ID
R1 — 1.0 kΩ 1/4 W Resistor
R2, R3 — 10 kΩ 1/4 W Resistor
Z1, Z2 — Microstrip Line .400L x .250W
Z3, Z4 — Microstrip Line .450L x .250W

Ckt Board Material — .060″ teflon–fiberglass, copper clad both sides, 2 oz. copper, ε_r = 2.55

Figure 2. 400 MHz Test Circuit

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TYPICAL CHARACTERISTICS

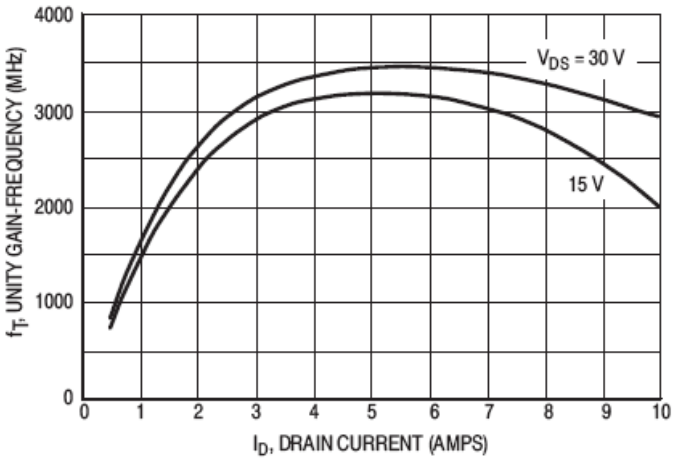


Figure 3. Common Source Unity Current Gain* Gain–Frequency versus Drain Current

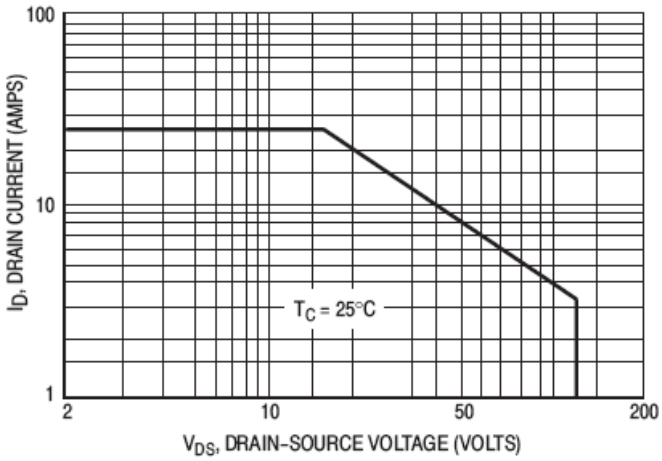
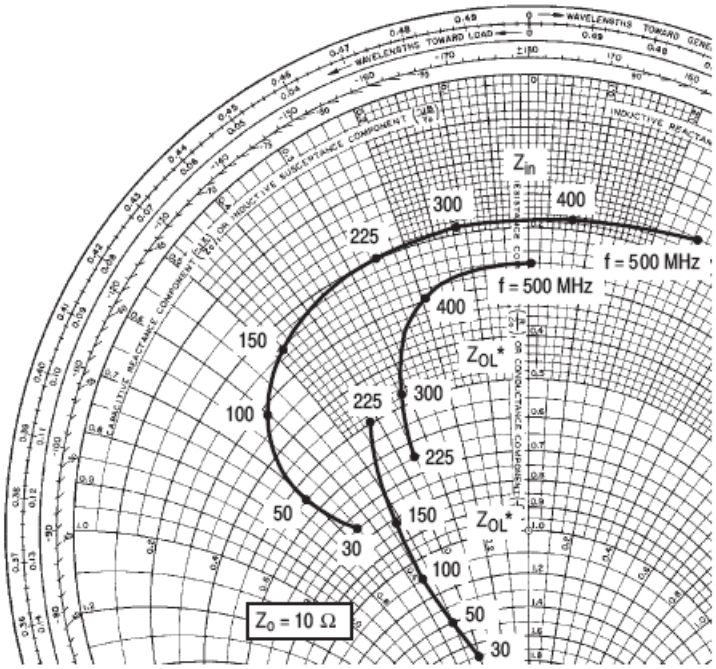


Figure 4. DC Safe Operating Area

* Data shown applies to each half of MRF176GU/GV



INPUT AND OUTPUT IMPEDANCE
MRF176GU/GV
V_{DD} = 50 V, I_{DQ} = 2 x 100 mA

f MHz	Z_{in} OHMS	Z_{OL}* OHMS
(P_{out} = 150 W)		
225	2.05 – j2.50	6.50 – j3.50
300	2.00 – j1.10	4.80 – j3.10
400	1.85 + j0.75	3.00 – j1.90
500	1.60 + j2.70	2.60 + j0.10
(P_{out} = 200 W)		
30	7.50 – j6.50	17.00 – j4.00
50	5.50 – j7.00	14.00 – j5.00
100	3.20 – j6.00	11.00 – j5.20
150	2.50 – j4.80	8.20 – j5.00
225	2.05 – j2.50	5.00 – j4.20

Z_{OL}* = Conjugate of the optimum load impedance into which the device output operates at a given output power, voltage and frequency.

NOTE: Input and output impedance values given are measured from gate to gate and drain to drain respectively.

Figure 5. Series Equivalent Input/Output Impedance

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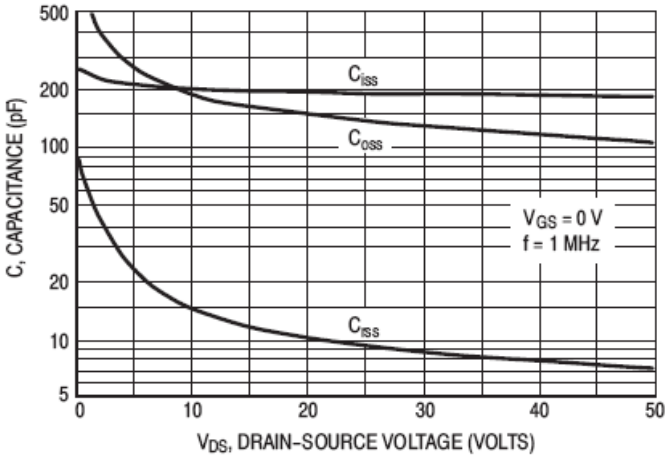


Figure 6. Capacitance versus Drain–Source Voltage*

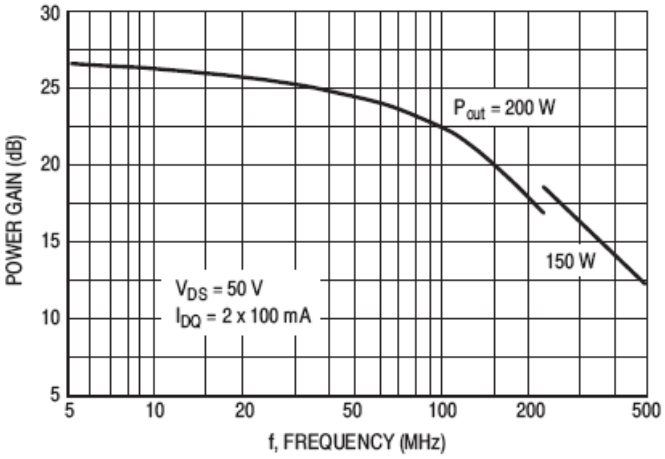


Figure 7. Power Gain versus Frequency

* Data shown applies to each half of MRF176GU/GV

MRF176GV

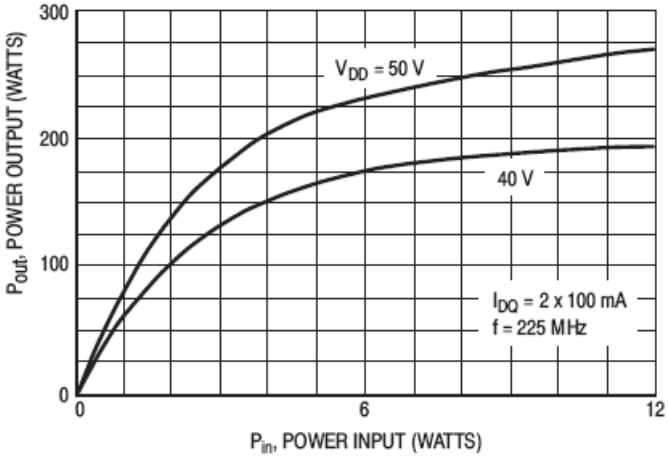


Figure 8. Power Input versus Power Output

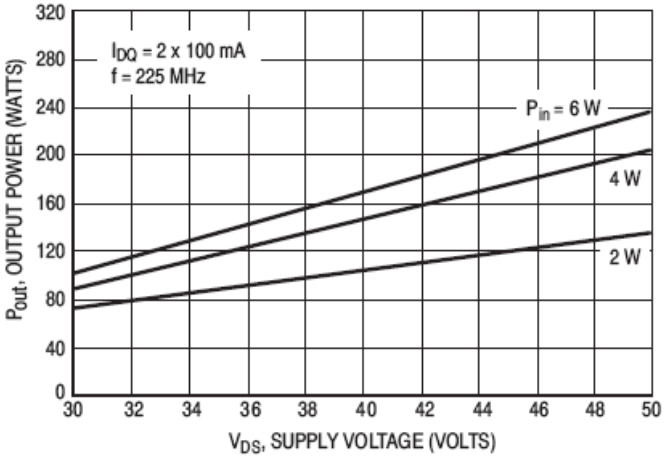


Figure 9. Output Power versus Supply Voltage

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TYPICAL CHARACTERISTICS
MRF176GU

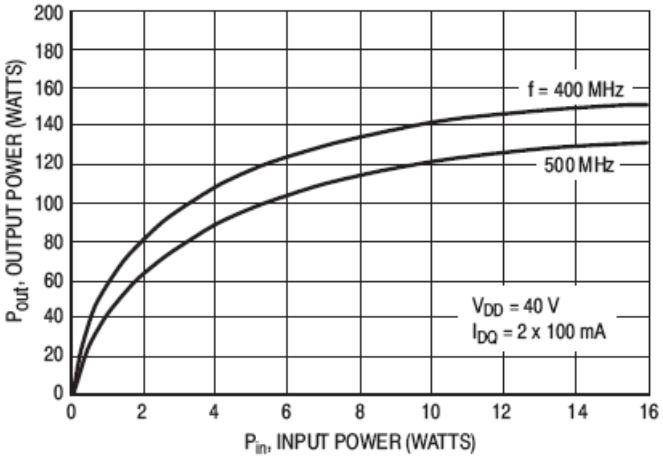


Figure 10. Output Power versus Input Power

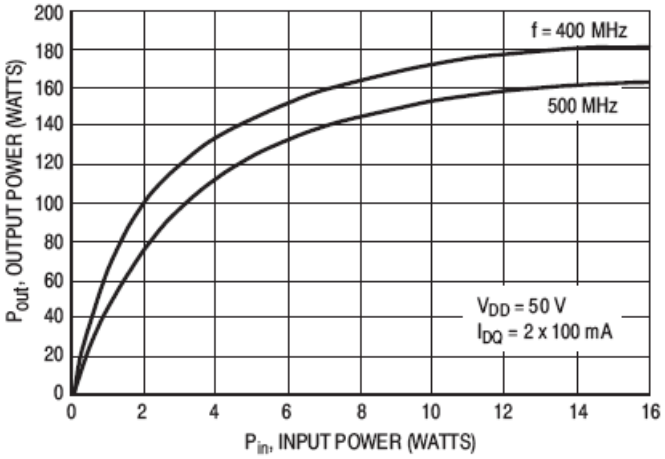


Figure 11. Output Power versus Input Power

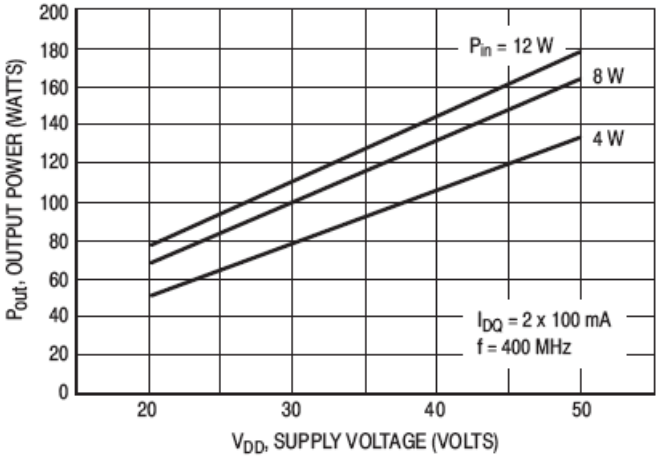


Figure 12. Output Power versus Supply Voltage

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Table 1. Common Source S–Parameters (V_{DS} = 50 V, I_D = 0.35 A)

f	S_{11}		S_{21}		S_{12}		S_{22}	
MHz	$\|S_{11}\|$	∠ϕ	$\|S_{21}\|$	∠ϕ	$\|S_{12}\|$	∠ϕ	$\|S_{22}\|$	∠ϕ
30	0.804	–159	17.80	87	0.018	–1	0.602	–149
40	0.851	–163	12.50	77	0.018	–9	0.606	–147
50	0.846	–166	10.40	70	0.018	–14	0.610	–149
60	0.842	–167	8.45	67	0.017	–16	0.652	–154
70	0.846	–168	7.28	65	0.017	–15	0.708	–157
80	0.858	–169	6.13	63	0.016	–15	0.786	–159
90	0.875	–170	5.36	59	0.015	–17	0.883	–158
100	0.890	–171	4.61	53	0.014	–22	0.916	–157
110	0.902	–171	4.04	46	0.013	–29	0.919	–158
120	0.909	–172	3.41	41	0.012	–31	0.857	–156
130	0.915	–172	2.92	39	0.011	–29	0.819	–157
140	0.920	–173	2.61	38	0.010	–24	0.816	–160
150	0.924	–173	2.41	38	0.009	–20	0.858	–162
160	0.928	–174	2.24	38	0.008	–21	0.951	–164
170	0.934	–174	2.10	35	0.007	–24	1.046	–164
180	0.940	–175	1.96	30	0.008	–23	1.130	–163
190	0.945	–175	1.78	24	0.007	–18	1.120	–165
200	0.950	–176	1.56	22	0.006	–8	1.030	–165
210	0.953	–176	1.36	20	0.005	2	0.940	–165
220	0.955	–176	1.22	21	0.004	7	0.900	–164
230	0.956	–177	1.14	21	0.004	6	0.940	–167
240	0.958	–177	1.08	22	0.004	13	0.940	–170
250	0.960	–178	1.05	21	0.005	29	1.010	–169
260	0.963	–178	1.01	18	0.006	44	1.120	–170
270	0.965	–178	0.96	13	0.005	55	1.160	–172
280	0.967	–179	0.87	10	0.005	57	1.150	–172
290	0.968	–179	0.78	8	0.005	47	1.030	–171
300	0.969	–180	0.72	8	0.006	46	0.964	–170
310	0.970	–180	0.68	11	0.008	58	0.926	–169
320	0.971	180	0.65	11	0.009	72	0.940	–172
330	0.973	179	0.61	10	0.009	83	0.980	–173
340	0.973	179	0.61	11	0.008	82	1.053	–175
350	0.974	179	0.58	7	0.008	70	1.095	–174
360	0.975	178	0.55	3	0.010	61	1.135	–173
370	0.975	178	0.50	1	0.013	65	1.086	–175
380	0.976	178	0.47	–1	0.013	74	1.045	–175
390	0.976	177	0.44	1	0.012	84	0.979	–174
400	0.976	177	0.42	4	0.010	84	0.940	–174
410	0.977	177	0.40	4	0.011	71	1.015	–175
420	0.978	176	0.39	4	0.015	67	1.038	–177

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Table 1. Common Source S–Parameters (V_{DS} = 50 V, I_D = 0.35 A) continued

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MHz	$\|S_{11}\|$	∠ϕ	$\|S_{21}\|$	∠ϕ	$\|S_{12}\|$	∠ϕ	$\|S_{22}\|$	∠ϕ
430	0.978	176	0.38	3	0.017	74	1.073	–178
440	0.979	176	0.37	0	0.017	83	1.091	–178
450	0.979	176	0.37	–2	0.015	86	1.107	–177
460	0.979	175	0.32	–6	0.013	71	1.118	–178
470	0.979	175	0.30	–5	0.015	60	1.003	–178
480	0.979	175	0.30	–3	0.019	66	0.975	–176
490	0.980	174	0.29	–1	0.021	80	0.963	–178
500	0.981	174	0.28	0	0.021	92	0.993	–179
600	0.972	172	0.24	–5	0.012	93	0.943	178
700	0.971	169	0.15	–8	0.027	75	0.999	176
800	0.971	166	0.13	–9	0.022	70	0.977	174
900	0.972	164	0.10	–5	0.032	73	0.972	172
1000	0.972	161	0.08	–9	0.030	83	0.999	169

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RF POWER MOSFET CONSIDERATIONS

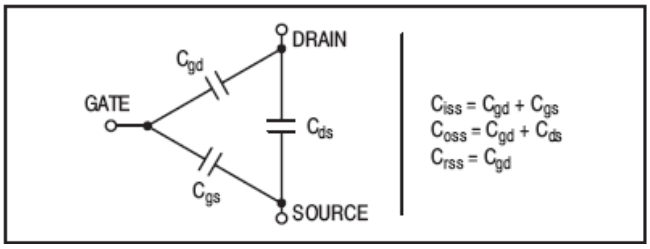
MOSFET CAPACITANCES

The physical structure of a MOSFET results in capacitors between the terminals. The metal oxide gate structure determines the capacitors from gate–to–drain (C_{gd}), and gate–to–source (C_{gs}). The PN junction formed during the fabrication of the MOSFET results in a junction capacitance from drain–to–source (C_{ds}).

These capacitances are characterized as input (C_{iss}), output (C_{oss}) and reverse transfer (C_{rss}) capacitances on data sheets. The relationships between the inter–terminal capacitances and those given on data sheets are shown below. The C_{iss} can be specified in two ways:

1. Drain shorted to source and positive voltage at the gate.

2. Positive voltage of the drain in respect to source and zerovolts at the gate. In the latter case the numbers are lower. However, neither method represents the actual operating conditions in RF applications.



The C_{iss} givenin the electrical characteristics table was measured using method 2 above. It should be noted that-C_{iss}, C_{oss}, C_{rss} are measured at zero drain current and are provided for general information about the device. They are not RF design parameters and no attempt should be made to use them as such.

LINEARITY AND GAIN CHARACTERISTICS

In addition to the typical IMD and power gain, data presented in Figure 3 may give the designer additional information on the capabilities of this device. The graph represents the small signal unity current gain frequency at a given drain current level. This is equivalent to f_T for bipolar transistors. Since this test is performed at a fast sweep speed, heating of the device does not occur. Thus, in normal use, the higher temperatures may degrade these characteristics to some extent.

DRAIN CHARACTERISTICS

One figure of merit for a FET is its static resistance in the full–on condition. This on–resistance, $V_{DS(on)}$, occurs in the linear region of the output characteristic and is specified under specific test conditions for gate–source voltage and drain current. For MOSFETs, $V_{DS(on)}$ has a positive temperature coefficient and constitutes an important design consideration at high temperatures, because it contributes to the power dissipation within the device.

GATE CHARACTERISTICS

The gate of the MOSFET is a polysilicon material, and is electrically isolated from the source by a layer of oxide. The input resistance is very high — on the order of 10^9 ohms — resulting in a leakage current of a few nanoamperes. Gate control is achieved by applying a positive voltage slightly in excess of the gate–to–source threshold voltage, $V_{GS(th)}$.

Gate Voltage Rating — Never exceed the gate voltage rating (or any of the maximum ratings on the front page). Exceeding the rated V_{GS} can result in permanent damage to the oxide layer in the gate region.

Gate Termination — The gates of this device are essentially capacitors. Circuits that leave the gate open–circuited or floating should be avoided. These conditions can result in turn–on of the devices due to voltage build–up on the input capacitor due to leakage currents or pickup.

Gate Protection — These devices do not have an internal monolithic zener diode from gate–to–source. If gate protection is required, an external zener diode is recommended. Using a resistor to keep the gate–to–source impedance low also helps damp transients and serves another important function. Voltage transients on the drain can be coupled to the gate through the parasitic gate–drain capacitance. If the gate–to–source impedance and the rate of voltage change on the drain are both high, then the signal coupled to the gate may be large enough to exceed the gate–threshold voltage and turn the device on.

HANDLING CONSIDERATIONS

The gate of the MOSFET, which is electrically isolated from the rest of the die by a very thin layer of SiO_2, may be damaged if the power MOSFET is handled or installed improperly. Exceeding the 40 V maximum gate–to–source voltage rating, $V_{GS(max)}$, can rupture the gate insulation and destroy the FET. RF Power MOSFETs are not nearly as susceptible as CMOS devices to damage due to static discharge because the input capacitances of power MOSFETs are much larger and absorb more energy before being charged to the gate breakdown voltage. However, once breakdown begins, there is enough energy stored in the gate–source capacitance to ensure the complete perforation of the gate oxide. To avoid the possibility of device failure caused by static discharge, precautions similar to those taken with small–signal MOSFET and CMOS devices apply to power MOSFETs.

When shipping, the devices should be transported only

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in antistatic bags or conductive foam. Upon removal from the packaging, careful handling procedures should be adhered to. Those handling the devices should wear grounding straps and devices not in the antistatic packaging should be kept in metal tote bins. MOSFETs should be handled by the case and not by the leads, and when testing the device, all leads should make good electrical contact before voltage is applied. As a final note, when placing the FET into the system it is designed for, soldering should be done with grounded equipment.

The gate of the power MOSFET could still be in danger after the device is placed in the intended circuit. If the gate may see voltage transients which exceed $V_{GS(max)}$, the circuit designer should place a 40 V zener across the gate and source terminals to clamp any potentially destructive spikes. Using a resistor to keep the gate–to–source impedance low also helps damp transients and serves another important function. Voltage transients on the drain can be coupled to the gate through the parasitic gate–drain capacitance. If the gate–to–source impedance and the rate of voltage change on the drain are both high, then the signal coupled to the gate may be large enough to exceed the gate–threshold voltage and turn the device on.

DESIGN CONSIDERATIONS

The MRF176G is a RF power N–channel enhancement mode field–effect transistor (FETs) designed for HF, VHF andUHF power amplifier applications. M/A-COM RF MOSFETs feature a vertical structure with a planar design. M/A-COM Application Note AN211A, FETs in Theory and Practice, is suggested reading for those not familiar with the construction and characteristics of FETs.

The major advantages of RF power FETs include high gain, low noise, simple bias systems, relative immunity from thermal runaway, and the ability to withstand severely mismatched loads without suffering damage. Power output can be varied over a wide range with a low power dc control signal.

DC BIAS

The MRF176G is an enhancement mode FET and, therefore, does not conduct when drain voltage is applied. Drain current flows when a positive voltage is applied to the gate. RF power FETs require forward bias for optimum performance. The value of quiescent drain current (I_{DQ}) is not critical for many applications. The MRF176G was characterized at I_{DQ} = 100 mA, each side, which is the suggested minimum-value of I_{DQ}. For special applications such as linear amplification, I_{DQ} may have to be selected to optimize the critical parameters. The gate is a dc open circuit and draws no current. Therefore, the gate bias circuit may be just a simple resistive divider network. Some applications may require a more elaborate bias system.

GAIN CONTROL

Power output of the MRF176G may be controlled from its rated value down to zero (negative gain) by varying the dc

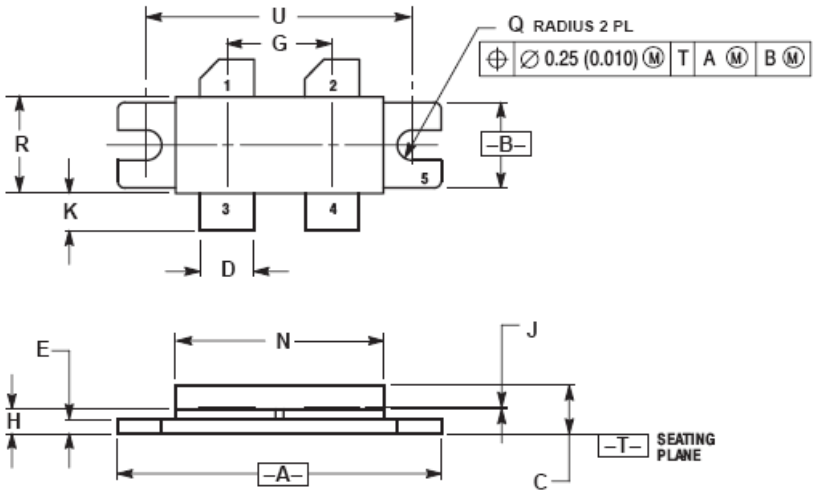
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PACKAGE DIMENSIONS



NOTES:
1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
2. CONTROLLING DIMENSION: INCH.

	INCHES		MILLIMETERS	
DIM	MIN	MAX	MIN	MAX
A	1.330	1.350	33.79	34.29
B	0.370	0.410	9.40	10.41
C	0.190	0.230	4.83	5.84
D	0.215	0.235	5.47	5.96
E	0.050	0.070	1.27	1.77
G	0.430	0.440	10.92	11.18
H	0.102	0.112	2.59	2.84
J	0.004	0.006	0.11	0.15
K	0.185	0.215	4.83	5.33
N	0.845	0.875	21.46	22.23
Q	0.060	0.070	1.52	1.78
R	0.390	0.410	9.91	10.41
U	1.100 BSC		27.94 BSC	

STYLE 2:
PIN 1. DRAIN
2. DRAIN
3. GATE
4. GATE
5. SOURCE

CASE 375–04
ISSUE D

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